

## 5-2 Current-Voltage Characteristics

**Reading Assignment:** *pp. 392 - 402*

We will find that BJTs are in many ways similar and analogous to MOSFETs!

For example, we will find:

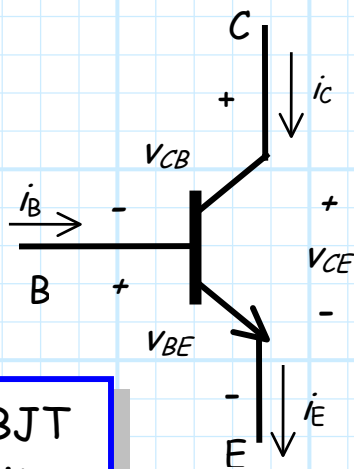
<u>BJT</u>	is analogous to	<u>MOSFET</u>
Base	"	Gate
Collector	"	Drain
Emitter	"	Source
Cutoff	"	Cutoff
Saturation	"	Triode
Active	"	Saturation
$i_C$	"	$i_D$
$V_{BE}$	"	$V_{GS}$
$V_{DS}$	"	$V_{CE}$

Look for these analogies to help you understand BJTs!

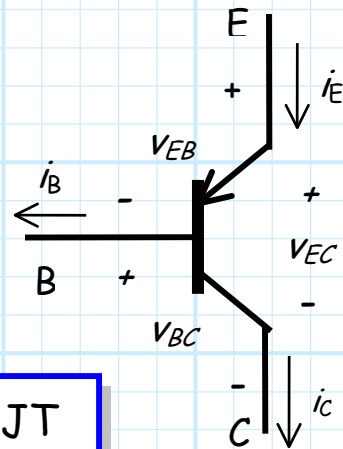
**HO: BJT Symbols and Conventions**

**HO: A Mathematical Description of BJT Behavior**

# BJT Symbols and Conventions



***nnp*** BJT  
Circuit  
Symbol



***pnp*** BJT  
Circuit  
Symbol

From KCL only we find:

$$i_E = i_B + i_C$$

From KVL only we find:

$$V_{CE} = V_{CB} + V_{BE} \quad (\text{nnp})$$

$$V_{EC} = V_{EB} + V_{BC} \quad (\text{pnp})$$

Note that:

- \* The circuit **symbols** are very **similar** to MOSFETs, with *npn* like N-MOS and *pnp* like P-MOS.
- \* Positive **current** is defined in **opposite** directions for *npn* and for *pnp* (just like N-MOS and PMOS!).
- \* The **voltages** are of **opposite** polarity for *npn* and *pnp*. Specifically, for *npn* we use  $v_{BE}$ ,  $v_{CE}$  and  $v_{CB}$ , whereas for *pnp* we use  $v_{EB}$ ,  $v_{EC}$  and  $v_{BC}$ . This convention typically results in **positive** voltage values for **both** *npn* and *pnp* (**unlike** the MOSFET convention!).
- \* The **base current**  $i_B$  is **not** equal to zero, therefore  $i_E \neq i_C$  (**unlike** MOSFETS)!

# A Mathematical Description of BJT Behavior

Now that we understand the **physical** behavior of a BJT—that is, the behavior for each of the three BJT **modes** (active, saturation, and cutoff)—we need to determine also the **mathematical** description of BJT behavior.

We will find that BJT behavior is in many ways **similar** to MOSFET behavior!

## ACTIVE MODE

We found earlier that forward biasing the **emitter-base** junction (EBJ) results in **collector** (drift) current. The junction voltage for the EBJ is  $v_{BE}$  (for npn).

Thus, in active mode, the voltage **base-to-emitter**  $v_{BE}$  controls the **collector** current  $i_C$ . Specifically, we find that:

$$i_C = I_S e^{v_{BE}/V_T} \quad (\text{nnp})$$

$$i_C = I_S e^{v_{EB}/V_T} \quad (\text{pnp})$$

Here we should note **two** things:

1. *The active mode equation is very **similar** to the p-n junction diode equation.*

No surprise here! The collector current is directly proportional to the **diffusion** current across the EBJ. That's why the equation is just like the diffusion current equation for a *pn* junction.

In fact,  $I_S$  is **scale current** (a device parameter), and  $V_T$  is the **thermal voltage** (25 mV)—the same values used to describe junction diodes!

2. *A BJT in ACTIVE mode is **analogous** to a MOSFET in SATURATION mode.*

Recall that for a MOSFET in SATURATION, the **drain** current  $i_D$  is "**controlled**" by the **gate-to-source** voltage  $V_{GS}$ .

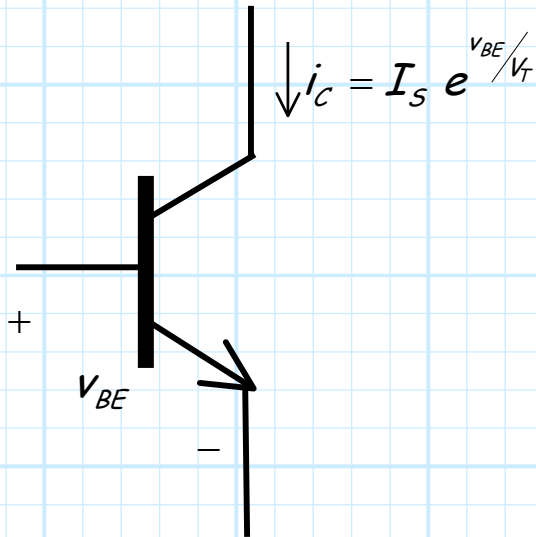
Likewise, for a BJT in ACTIVE mode, the **collector** current  $i_C$  is "**controlled**" by the **base-to-emitter** voltage  $V_{BE}$ .

Note the **analogies!**

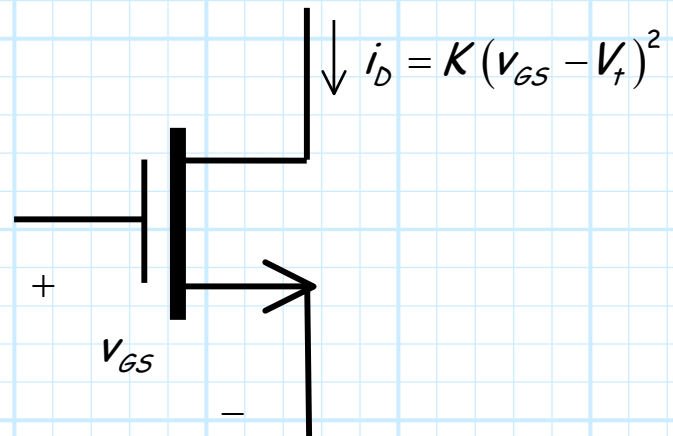
$i_D$  analogous to  $i_C$

$V_{BE}$  analogous to  $V_{GS}$

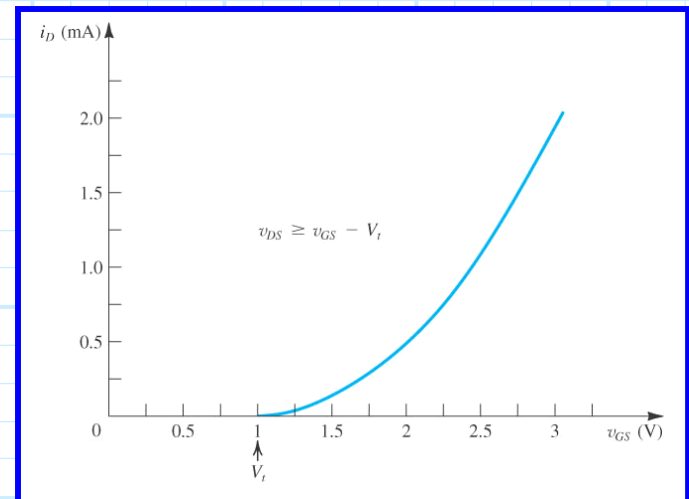
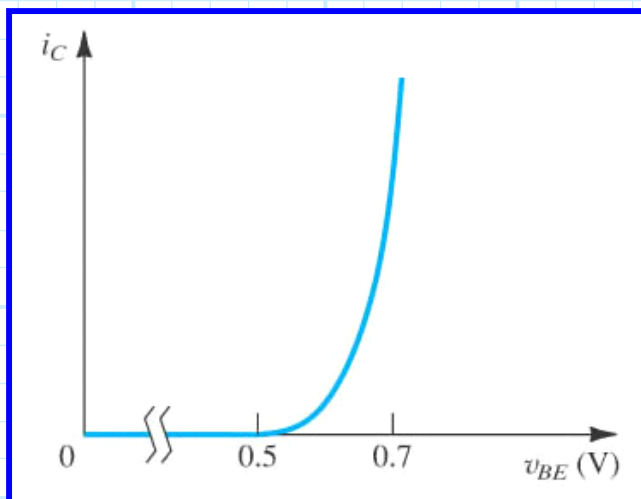
ACTIVE analogous to SATURATION



*npn* in ACTIVE mode



*NMOS* in SATURATION mode



Note also that a **necessary** (but not sufficient) condition for a *npn* BJT to be in ACTIVE mode is that  $v_{BE} > 0$  (i.e., the EBJ is forward biased).

This is **analogous** to an NMOS in SATURATION, where a **necessary** (but not sufficient) condition is that  $v_{GS} > V_t$  (i.e., the channel is conducting).

Likewise, for a BJT to be in the **ACTIVE** mode, the **CBJ** must be in **reverse bias** (i.e.,  $v_{BC} < 0$ ). Assuming that the forward biased EBJ results in  $v_{BE} \approx 0.7\text{V}$ , we can use **KVL** to determine that the CBJ will be reverse biased only when:

$$v_{CE} > 0.7\text{V} \quad \text{for } npn \text{ in ACTIVE}$$

$$v_{EC} > 0.7\text{V} \quad \text{for } pnp \text{ in ACTIVE}$$

These statements above are **analogous** to the MOSFET inequality  $v_{DS} > v_{GS} - V_t$  for MOSFET SAT. (more on this later!).

Now, we are tempted to make **another analogy** between base **current**  $i_B$  and gate **current**  $i_G$ , but here the analogies **end!**

Recall  $i_G = 0$  **always**, but for BJTs we find that  $i_B$  is **not equal to zero** (generally).



Instead, we found that although **most** of the charge carriers (e.g., holes or free electrons) diffusing across the EBJ end up "**drifting**" across the CBJ into the **collector**, **some** charge carriers do "exit" the **base** terminal.

Recall, however, that for every **one** charge carrier that leaves the **base** terminal, there are typically **50 to 250** (depending on the BJT) charge carriers that drift into the collector.

As a result, the **collector current** for ACTIVE mode is typically 50 to 250 times **larger** than the **base current**! I.E.:

$$50 < \frac{i_C}{i_B} < 250 \quad \text{typically, for BJT ACTIVE}$$

The **precise** value of this ratio is the **device parameter**  $\beta$  (**beta**):

$$\beta \doteq \frac{i_C}{i_B} \quad \text{for BJT ACTIVE mode}$$

Thus, we find that the **base current** can be expressed as:

$$i_B = \frac{i_C}{\beta} = \frac{I_S}{\beta} e^{v_{BE}/V_T} \quad (\text{nnp})$$

$$i_B = \frac{i_C}{\beta} = \frac{I_S}{\beta} e^{v_{EB}/V_T} \quad (\text{pnp})$$

Likewise, from **KCL**, we can determine the **emitter current** for a BJT in the **ACTIVE** mode:

$$\begin{aligned}i_E &= i_C + i_B \\ &= \beta i_B + i_B \\ &= (\beta + 1) i_B\end{aligned}$$

Or similarly,

$$\begin{aligned}i_E &= i_C + i_B \\ &= i_C + \frac{i_C}{\beta} \\ &= \left(1 + \frac{1}{\beta}\right) i_C \\ &= \left(\frac{\beta + 1}{\beta}\right) i_C\end{aligned}$$

An **alternative** to device parameter  $\beta$  is the **device parameter**  $\alpha$ , defined as:

$$\alpha = \frac{\beta}{\beta + 1}$$

Note that the value of  $\alpha$  will be just **slightly less than one**.

We can thus **alternatively** express the current relationships as:

$$i_C = \alpha i_E \quad i_B = (1 - \alpha) i_E$$

And therefore:

$$i_E = \frac{i_C}{\alpha} = \frac{I_S}{\alpha} e^{v_{BE}/V_T} \quad (\text{npn})$$

$$i_E = \frac{i_C}{\alpha} = \frac{I_S}{\alpha} e^{v_{EB}/V_T} \quad (\text{pnp})$$

Recall that the **exponential** expression for a *pn* junction turned out to be of **limited** use, as it typically led to unsolvable **transcendental equations**.

The **same** is true for **these** exponential equations! We will thus generally use the equations below to **approximate** the behavior of a BJT in the **ACTIVE** mode:

$$v_{BE} \approx 0.7 \quad i_C = \beta i_B \quad v_{CE} > 0.7 \quad (\text{npn in ACTIVE})$$

$$v_{EB} \approx 0.7 \quad i_C = \beta i_B \quad v_{EC} > 0.7 \quad (\text{pnp in ACTIVE})$$

## SATURATION MODE

Recall for BJT **SATURATION** mode that **both** the CBJ and the EBJ are **forward biased**.

Thus, the collector current is due to **two** physical mechanisms, the **first** being charge carriers (holes or free-electrons) that

**drift** across the CBJ (just like ACTIVE mode), and the **second** being charge carriers that **diffuse** across the forward biased CBJ!

As a result, a **second term** appears in our mathematical description of **collector current** (when the BJT is in SATURATION):

$$i_C = I_S e^{v_{BE}/V_T} - \left( \frac{I_S}{\alpha_R} \right) e^{v_{BC}/V_T} \quad (\text{nnp})$$

$$i_C = I_S e^{v_{EB}/V_T} - \left( \frac{I_S}{\alpha_R} \right) e^{v_{CB}/V_T} \quad (\text{pnp})$$

where  $\alpha_R$  represents the **same** device parameter  $\alpha$  discussed earlier (for ACTIVE mode), with the only difference that it specifies the value of  $\alpha$  specifically for the **CBJ**.

This second term describes the current due to **diffusion** across the CBJ. Note that this current is in the **opposite** direction of the drift current (the first term), hence the **minus** sign in the second term.

Now using **KVL** (i.e.,  $v_{CE} = v_{CB} + v_{BE}$ ), we can write this collector current equation as:

$$i_C = I_S e^{v_{BE}/V_T} - \left( \frac{I_S}{\alpha_R} \right) e^{(v_{BE}-v_{CE})/V_T}$$

$$= I_S e^{v_{BE}/V_T} \left( 1 - \frac{e^{-v_{CE}/V_T}}{\alpha_R} \right)$$

Thus, we can conclude:

$$i_C = I_S e^{v_{BE}/V_T} \left( 1 - \frac{e^{-v_{CE}/V_T}}{\alpha_R} \right) \quad \text{for } npn \text{ in SAT.}$$

$$i_C = I_S e^{v_{EB}/V_T} \left( 1 - \frac{e^{-v_{EC}/V_T}}{\alpha_R} \right) \quad \text{for } pnp \text{ in SAT.}$$

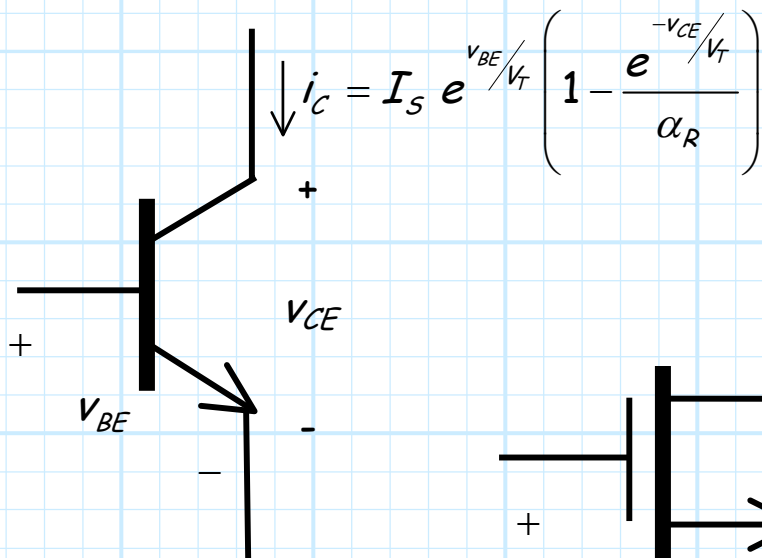
It is thus clear that for a BJT in SATURATION, the collector current  $i_C$  is dependent on **both**  $v_{BE}$  and  $v_{CE}$ .

This is precisely **analogous** to the TRIODE mode for MOSFETS!

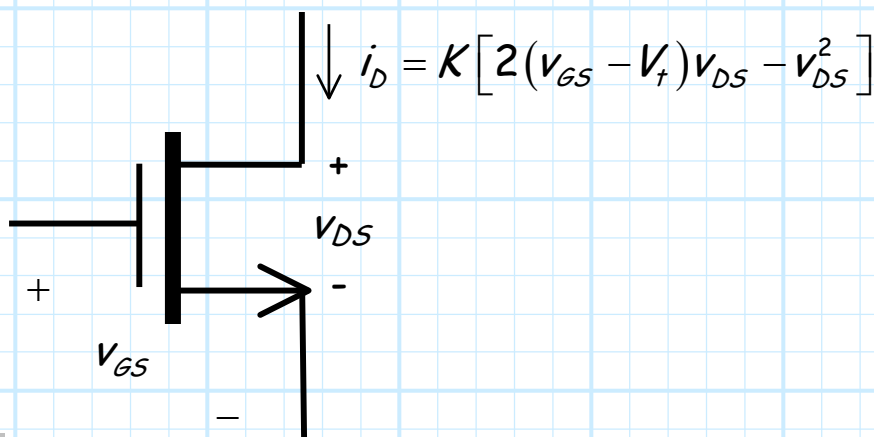
Recall for **triode** mode, drain current  $i_D$  is dependent on both  $v_{GS}$  and  $v_{DS}$ . We thus have discovered **two** new analogies:

$V_{CE}$  analogous to  $V_{DS}$

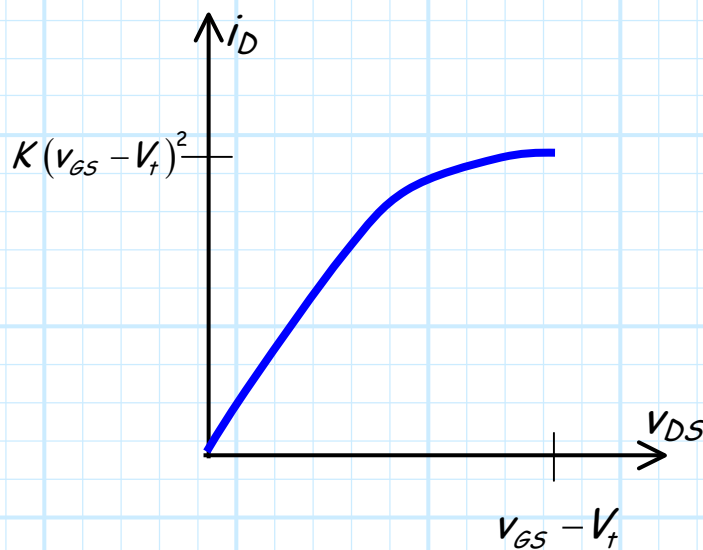
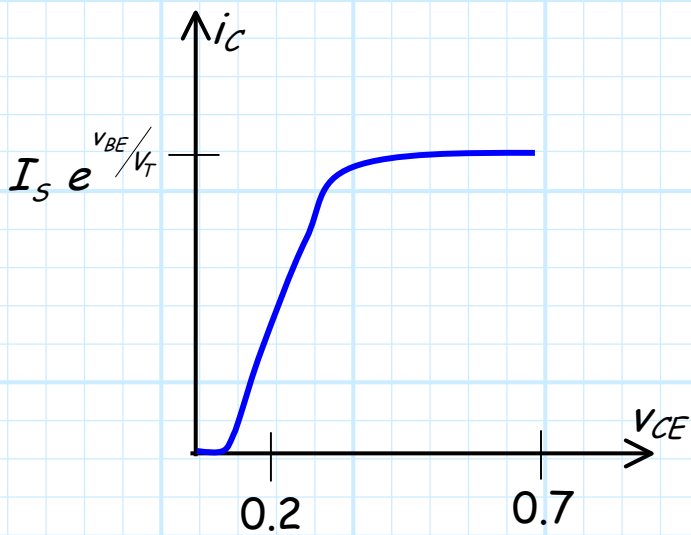
SATURATION analogous to TRIODE



**npn in SAT. mode**



**NMOS in TRIODE mode**



Now, a BJT is in SATURATION mode if **both** the CBJ and the EBJ are **forward biased**. Assuming that  $v_{BE} \approx 0.7V$  if the EBJ is forward biased, the CBJ voltage  $v_{BC}$  will be positive **only** if (using KVL):

$$\begin{aligned}v_{BC} &> 0 \\v_{BE} - v_{CE} &> 0 \\0.7 - v_{CE} &> 0 \\v_{CE} &< 0.7\end{aligned}$$

Thus, we can conclude that a **necessary** (but not sufficient) condition for a BJT to be in SATURATION is:

$$v_{CE} < 0.7 \quad \text{for } npn \text{ in SAT.}$$

$$v_{EC} < 0.7 \quad \text{for } pnp \text{ in SAT.}$$

These inequalities are **analogous** to the MOSFET inequalities:

$$v_{DS} < v_{GS} - V_t \quad \text{for NMOS in Triode}$$

$$v_{DS} > v_{GS} - V_t \quad \text{for PMOS in Triode}$$

Now, we note for the BJT SATURATION mode that the **collector current will always be less** than that in ACTIVE mode with the same value of  $v_{BE}$ :

$$I_S e^{v_{BE}/V_T} \left( 1 - \frac{e^{-v_{CE}/V_T}}{\alpha_R} \right) < I_S e^{v_{BE}/V_T} \quad \text{for all } v_{CE}$$

Thus, we can **equivalently** state that the collector current in SATURATION will be **less** than the value  $\beta i_B$ :

$$i_C < \beta i_B \quad \text{for BJT in SAT.}$$

This of course means that the **base** current in SAT. is **greater** than  $i_C/\beta$  (i.e., the base current in active):

$$i_B > \frac{i_C}{\beta} \quad \text{for BJT in SAT.}$$

Likewise, this means that:

$$i_E < (\beta + 1)i_B \quad \text{and} \quad i_C < \alpha i_E \quad \text{for BJT in SAT.}$$

But remember KCL is still valid for BJTs in SATURATION (it's **always** valid!):

$$i_E = i_B + i_C \quad (\text{KCL})$$

Finally, we should again note that the **exponential** equations presented for SATURATION mode are **not** particularly useful for analyzing BJT circuits (that **transcendental** equation thing again!).



Thus, we describe a BJT in SATURATION with some **approximate** equations. Since both CBJ and EBJ are forward biased, we assume that  $v_{BE} \approx 0.7V$  and that  $v_{BC} \approx 0.5V$ , resulting in the following **approximate** description for a BJT in SATURATION:

$$v_{BE} \approx 0.7V \quad v_{CE} \approx 0.2V \quad i_C < \beta i_B \quad \text{for } npn \text{ in SAT.}$$

$$v_{EB} \approx 0.7V \quad v_{EC} \approx 0.2V \quad i_C < \beta i_B \quad \text{for } pnp \text{ in SAT.}$$

### CUTOFF MODE

Cutoff mode for BJTs is obviously **analogous** to cutoff mode for MOSFETS.

In both cases the transistor currents are **zero!**

$$i_E = i_B = i_C = 0 \quad \text{for BJTs in CUTOFF}$$

Note that a BJT is in cutoff if **both** EBJ and CBJ are in **reverse bias**. This is true if:

$v_{BE} < 0$  and  $v_{BC} < 0$  for *npn* in CUTOFF

$v_{EB} < 0$  and  $v_{CB} < 0$  for *pnp* in CUTOFF